

MC74AC32, MC74ACT32

Quad 2-Input OR Gate

- Outputs Source/Sink 24 mA
- 'ACT32 Has TTL Compatible Inputs

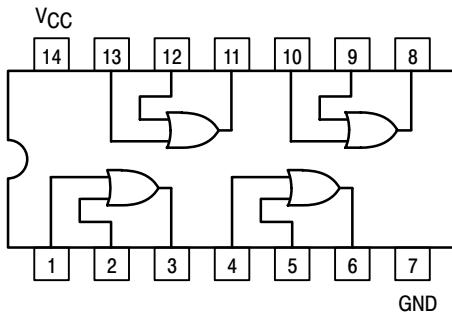
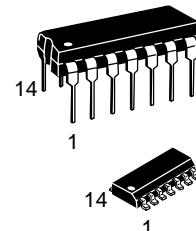


Figure 1. Pinout: 14-Lead Packages Conductors
(Top View)

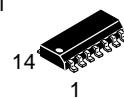


ON Semiconductor™

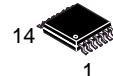
<http://onsemi.com>



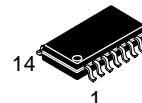
PDIP-14
N SUFFIX
CASE 646



SO-14
D SUFFIX
CASE 751A



TSSOP-14
DT SUFFIX
CASE 948G



EIAJ-14
M SUFFIX
CASE 965

ORDERING INFORMATION

Device	Package	Shipping
MC74AC32N	PDIP-14	25 Units/Rail
MC74ACT32N	PDIP-14	25 Units/Rail
MC74AC32D	SOIC-14	55 Units/Rail
MC74AC32DR2	SOIC-14	2500 Tape & Reel
MC74ACT32D	SOIC-14	55 Units/Rail
MC74ACT32DR2	SOIC-14	2500 Tape & Reel
MC74AC32DT	TSSOP-14	96 Units/Rail
MC74AC32DTR2	TSSOP-14	2500 Tape & Reel
MC74ACT32DT	TSSOP-14	96 Units/Rail
MC74ACT32DTR2	TSSOP-14	2500 Tape & Reel
MC74AC32M	EIAJ-14	50 Units/Rail
MC74AC32MEL	EIAJ-14	2000 Tape & Reel
MC74ACT32M	EIAJ-14	50 Units/Rail
MC74ACT32MEL	EIAJ-14	2000 Tape & Reel

DEVICE MARKING INFORMATION

See general marking information in the device marking section on page 93 of this data sheet.

MC74AC32, MC74ACT32

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Typ	Max	Unit
V _{CC}	Supply Voltage	'AC	2.0	5.0	6.0
		'ACT	4.5	5.0	5.5
V _{in} , V _{out}	DC Input Voltage, Output Voltage (Ref. to GND)	0	—	V _{CC}	V
t _r , t _f	Input Rise and Fall Time (Note 1) 'AC Devices except Schmitt Inputs	V _{CC} @ 3.0 V	—	150	—
		V _{CC} @ 4.5 V	—	40	—
		V _{CC} @ 5.5 V	—	25	—
t _r , t _f	Input Rise and Fall Time (Note 2) 'ACT Devices except Schmitt Inputs	V _{CC} @ 4.5 V	—	10	—
		V _{CC} @ 5.5 V	—	8.0	—
T _J	Junction Temperature (PDIP)	—	—	140	°C
T _A	Operating Ambient Temperature Range	-40	25	85	°C
I _{OH}	Output Current – High	—	—	-24	mA
I _{OL}	Output Current – Low	—	—	24	mA

1. V_{in} from 30% to 70% V_{CC}; see individual Data Sheets for devices that differ from the typical input rise and fall times.
 2. V_{in} from 0.8 V to 2.0 V; see individual Data Sheets for devices that differ from the typical input rise and fall times.

DC CHARACTERISTICS

Symbol	Parameter	V _{CC} (V)	74AC		Unit	Conditions		
			T _A = +25°C					
			Typ	Guaranteed Limits				
V _{IH}	Minimum High Level Input Voltage	3.0 4.5 5.5	1.5 2.25 2.75	2.1 3.15 3.85	V	V _{OUT} = 0.1 V or V _{CC} – 0.1 V		
V _{IL}	Maximum Low Level Input Voltage	3.0 4.5 5.5	1.5 2.25 2.75	0.9 1.35 1.65	V	V _{OUT} = 0.1 V or V _{CC} – 0.1 V		
V _{OH}	Minimum High Level Output Voltage	3.0 4.5 5.5	2.99 4.49 5.49	2.9 4.4 5.4	V	I _{OUT} = -50 μA		
		3.0 4.5 5.5	— — —	2.56 3.86 4.86	V	*V _{IN} = V _{IL} or V _{IH} -12 mA I _{OH} -24 mA -24 mA		
V _{OL}	Maximum Low Level Output Voltage	3.0 4.5 5.5	0.002 0.001 0.001	0.1 0.1 0.1	V	I _{OUT} = 50 μA		
		3.0 4.5 5.5	— — —	0.36 0.36 0.36	V	*V _{IN} = V _{IL} or V _{IH} 12 mA I _{OL} 24 mA 24 mA		
I _{IN}	Maximum Input Leakage Current	5.5	—	±0.1	±1.0	μA	V _I = V _{CC} , GND	
I _{OLD}	†Minimum Dynamic Output Current	5.5	—	—	75	mA	V _{OLD} = 1.65 V Max	
I _{OHD}		5.5	—	—	-75	mA	V _{OHD} = 3.85 V Min	
I _{CC}	Maximum Quiescent Supply Current	5.5	—	4.0	40	μA	V _{IN} = V _{CC} or GND	

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

NOTE: I_{IN} and I_{CC} @ 3.0 V are guaranteed to be less than or equal to the respective limit @ 5.5 V V_{CC}.

MC74AC32, MC74ACT32

AC CHARACTERISTICS (For Figures and Waveforms – See Section 3 of the ON Semiconductor FACT Data Book, DL138/D)

Symbol	Parameter	V _{CC} * (V)	74AC			74AC		Unit	Fig. No.		
			T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF					
			Min	Typ	Max	Min	Max				
t _{PLH}	Propagation Delay	3.3 5.0	1.5 1.5	7.0 5.5	9.0 7.5	1.5 1.0	10.0 8.5	ns	3-5		
t _{PHL}	Propagation Delay	3.3 5.0	1.5 1.5	7.0 5.0	8.5 7.0	1.0 1.0	9.0 7.5	ns	3-5		

*Voltage Range 3.3 V is 3.3 V ±0.3 V.

Voltage Range 5.0 V is 5.0 V ±0.5 V.

DC CHARACTERISTICS

Symbol	Parameter	V _{CC} (V)	74ACT		74ACT		Unit	Conditions		
			T _A = +25°C		T _A = -40°C to +85°C					
			Typ	Guaranteed Limits	Typ	Guaranteed Limits				
V _{IH}	Minimum High Level Input Voltage	4.5 5.5	1.5 1.5	2.0 2.0	2.0 2.0		V	V _{OUT} = 0.1 V or V _{CC} – 0.1 V		
V _{IL}	Maximum Low Level Input Voltage	4.5 5.5	1.5 1.5	0.8 0.8	0.8 0.8		V	V _{OUT} = 0.1 V or V _{CC} – 0.1 V		
V _{OH}	Minimum High Level Output Voltage	4.5 5.5	4.49 5.49	4.4 5.4	4.4 5.4		V	I _{OUT} = -50 μA		
		4.5 5.5	– –	3.86 4.86	3.76 4.76		V	*V _{IN} = V _{IL} or V _{IH} I _{OH} -24 mA -24 mA		
V _{OL}	Maximum Low Level Output Voltage	4.5 5.5	0.001 0.001	0.1 0.1	0.1 0.1		V	I _{OUT} = 50 μA		
		4.5 5.5	– –	0.36 0.36	0.44 0.44		V	*V _{IN} = V _{IL} or V _{IH} I _{OL} 24 mA		
I _{IN}	Maximum Input Leakage Current	5.5	–	±0.1	±1.0		μA	V _I = V _{CC} , GND		
ΔI _{CCT}	Additional Max. I _{CC} /Input	5.5	0.6	–	1.5		mA	V _I = V _{CC} – 2.1 V		
I _{OLD}	†Minimum Dynamic Output Current	5.5	–	–	75		mA	V _{OLD} = 1.65 V Max		
I _{OHD}		5.5	–	–	-75		mA	V _{OHD} = 3.85 V Min		
I _{CC}	Maximum Quiescent Supply Current	5.5	–	4.0	40		μA	V _{IN} = V _{CC} or GND		

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

MC74AC32, MC74ACT32

AC CHARACTERISTICS (For Figures and Waveforms – See Section 3 of the ON Semiconductor FACT Data Book, DL138/D)

Symbol	Parameter	V _{CC} * (V)	74ACT			74ACT		Unit	Fig. No.		
			T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF					
			Min	Typ	Max	Min	Max				
t _{PLH}	Propagation Delay	5.0	1.0	–	9.0	1.0	10.0	ns	3–6		
t _{PHL}	Propagation Delay	5.0	1.0	–	9.0	1.0	10.0	ns	3–6		

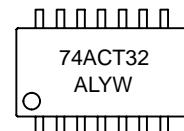
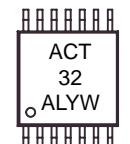
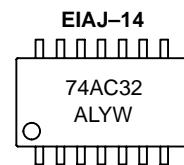
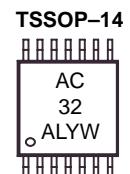
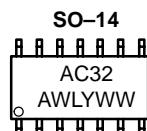
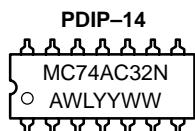
*Voltage Range 5.0 V is 5.0 V ±0.5 V.

CAPACITANCE

Symbol	Parameter	Value Typ	Unit	Test Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = 5.0 V
C _{PD}	Power Dissipation Capacitance	20	pF	V _{CC} = 5.0 V

MC74AC32, MC74ACT32

MARKING DIAGRAMS



A = Assembly Location

WL, L = Wafer Lot

YY, Y = Year

WW, W = Work Week